	Application No.	Applicant(s)	
Notice of Allowability	10/006,891	CHANDRA ET AL.	
	Examiner	Art Unit	
	Brian J. Sines	1743	
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	ars on the cover sheet was (OR REMAINS) CLOSED is or other appropriate comm GHTS. This application is	ith the correspondence addr n this application. If not include unication will be mailed in due	ed course. THIS
1. \boxtimes This communication is responsive to <u>the response filed 10/</u>	<u>6/2004</u> .		
2. The allowed claim(s) is/are <u>1-3,6-12 and 27-38</u> .			
3. \boxtimes The drawings filed on <u>13 November 2001</u> are accepted by	the Examiner.		
 4. Acknowledgment is made of a claim for foreign priority un a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 	been received. been received in Application	on No	tion from the
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONMI THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file ENT of this application.	e a reply complying with the rec	quirements
5. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give	tted. Note the attached EXAs reason(s) why the oath o	AMINER'S AMENDMENT or N r declaration is deficient.	OTICE OF
 CORRECTED DRAWINGS (as "replacement sheets") must (a) including changes required by the Notice of Draftspersor 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1.1 each sheet. Replacement sheet(s) should be labeled as such in the paper No./Mail DFOSIT OF and/or INFORMATION about the depose attached Examiner's comment regarding REQUIREMENT F 	Amendment / Comment or 34(c)) should be written on the header according to 37 CF	r in the Office action of he drawings in the front (not the R 1.121(d). ERIAL must be submitted. N	
Attachment(s) 1. ☐ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview So Paper No./ 3), 7. ☑ Examiner's	formal Patent Application (PTC ummary (PTO-413), 'Mail Date Amendment/Comment Statement of Reasons for Allo	·

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DETAILED ACTION

Response to Arguments

Applicant's arguments, filed 10/6/2004, with respect to the rejection of claims 1 – 3, 6 – 12 and 27 – 38 under 35 U.S.C. 102(b) as being anticipated by Chandra et al. (WO 00/39570) have been fully considered and are persuasive. This rejection has been withdrawn.

Allowable Subject Matter

Claims 1 - 3, 6 - 12 and 27 - 38 are allowed.

The following is an examiner's statement of reasons for allowance:

Regarding claims 1 and 37, the cited prior art neither teach nor fairly suggest a sensor apparatus for detecting a target matter, wherein the sensor apparatus comprises: a chemical sensitive layer operable to react when exposed to the target matter; a piezoresistive material coupled to the chemical sensitive layer, wherein the chemical sensitive layer has a thickness thin enough, such that adsorption of the target matter into the chemical sensitive layer creates an interfacial tension at the interface of the chemical sensitive layer and the piezoresistive material that changes the electrical resistance of the piezoresistive material, but thick enough, such that the reaction the target matter with the chemical sensitive layer does not effect the bulk properties of the chemical sensitive layer enough to change the electrical resistance of the piezoresistive material; and an electrical circuit coupled to the piezoresistive material operable to detect the change in the electrical resistance of the piezoresistive material due to the interfacial tension.

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Regarding claim 27, the cited prior art neither teach nor fairly suggest a method for detecting a target matter, wherein the method comprises the steps of: coupling the chemical sensitive layer to a piezoresistive material, wherein the chemical sensitive layer is configured such that the reaction of the target matter with the chemical sensitive layer creates an interfacial tension at the interface of the chemical sensitive layer and the piezoresistive material that changes the electrical resistance of the piezoresistive material, but such that the reaction of the target matter with the chemical sensitive layer does not affect the bulk properties of the chemical sensitive layer enough to change the electrical resistance of the piezoresistive material; exposing the chemical sensitive layer to the target matter; and detecting a change in the electrical resistance of the piezoresistive material due to the interfacial tension.

Regarding claim 38, the cited prior art neither teach nor fairly suggest a method for detecting a target matter, wherein the method comprises the steps of: exposing a chemical sensitive layer to the target matter; creating, by reaction of the chemical sensitive layer with the target matter, an interfacial tension at an interface of the chemical sensitive layer and a piezoresistive material that changes the electrical resistance of the piezoresistive material without affecting the bulk properties of the chemical sensitive layer enough to change the electrical resistance of the piezoresistive material; and detecting a change in the electrical resistance of the piezoresistive material due to the created interfacial tension.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably

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accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Brian J. Sines, Ph.D. whose telephone number is (571) 272-1263. The examiner can normally be reached on Monday - Friday (11 AM - 8 PM EST).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jill A. Warden can be reached on (571) 272-1267. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

/Jill Warden
Supervisory Patent Examiner
Technology Center 1700